BF904A; BF904AR; BF904AWR

N-channel dual gate MOS-FETs

Rev. 04 — 13 November 2007

Product data sheet

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NXP Semiconductors



N-channel dual gate MOS-FETs

BF904A; BF904AR; BF904AWR

FEATURES

- Specially designed for use at 5 V supply voltage
- Short channel transistor with high transfer admittance to input capacitance ratio
- Low noise gain controlled amplifier up to 1 GHz
- Superior cross-modulation performance during AGC.

APPLICATIONS

 VHF and UHF applications with 3 to 7 V supply voltage such as television tuners and professional communications equipment.

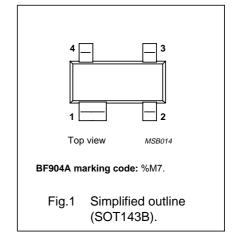
DESCRIPTION

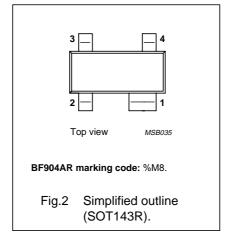
Enhancement type field-effect transistors. The transistors consist of an amplifier MOS-FET with source and substrate interconnected and an internal bias circuit to ensure good cross-modulation performance during AGC.

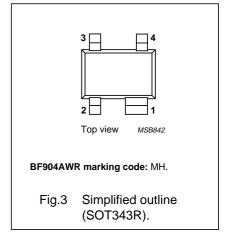
The BF904A, BF904AR and BF904AWR are encapsulated in the SOT143B, SOT143R and SOT343R plastic packages respectively.

PINNING

PIN	DESCRIPTION
1	source
2	drain
3	gate 2
4	gate 1







QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{DS}	drain-source voltage		_	_	7	٧
I _D	drain current		_	_	30	mA
P _{tot}	total power dissipation	T _s ≤ 110 °C	_	_	200	mW
y _{fs}	forward transfer admittance		22	25	30	mS
C _{ig1-ss}	input capacitance at gate 1		_	2.2	2.6	pF
C _{rss}	reverse transfer capacitance	f = 1 MHz	_	25	35	fF
F	noise figure	f = 800 MHz	_	2	_	dB
T _i	operating junction temperature		_	_	150	°C

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

N-channel dual gate MOS-FETs

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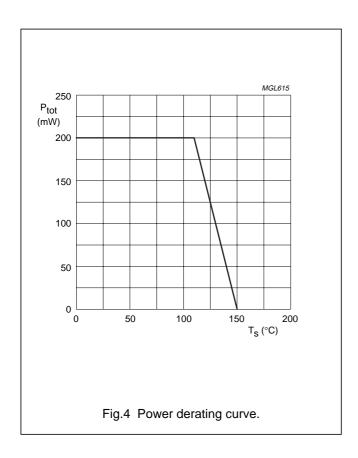
LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	7	V
I _D	drain current		_	30	mA
I _{G1}	gate 1 current		_	±10	mA
I _{G2}	gate 2 current		_	±10	mA
P _{tot}	total power dissipation	T _s ≤ 110 °C; note 1; see Fig.4	_	200	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	operating junction temperature		_	150	°C

Note

1. T_s is the temperature of the soldering point of the source lead.



N-channel dual gate MOS-FETs

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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-s}	thermal resistance from junction to soldering point	note 1	200	K/W

Note

1. Soldering point of the source lead.

STATIC CHARACTERISTICS

 $T_j = 25$ °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{(BR)G1-SS}	gate 1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0$; $I_{G1-S} = 10 \text{ mA}$	6	15	V
V _{(BR)G2-SS}	gate 2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0$; $I_{G2-S} = 10 \text{ mA}$	6	15	V
V _{(F)S-G1}	forward source-gate 1 voltage	$V_{G2-S} = V_{DS} = 0$; $I_{S-G1} = 10 \text{ mA}$	0.5	1.5	V
V _{(F)S-G2}	forward source-gate 2 voltage	$V_{G1-S} = V_{DS} = 0$; $I_{S-G2} = 10 \text{ mA}$	0.5	1.5	V
V _{G1-S(th)}	gate 1-source threshold voltage	$V_{G2-S} = 4 \text{ V}; V_{DS} = 5 \text{ V}; I_D = 20 \mu\text{A}$	0.3	1	V
V _{G2-S(th)}	gate 2-source threshold voltage	$V_{G1-S} = V_{DS} = 5 \text{ V}; I_D = 20 \mu\text{A}$	0.3	1.2	V
I _{DSX}	drain-source current	$V_{G2-S} = 4 \text{ V; } V_{DS} = 5 \text{ V;}$ $R_{G1} = 120 \text{ k}\Omega; \text{ note 1}$	8	13	mA
I _{G1-SS}	gate 1 cut-off current	$V_{G2-S} = V_{DS} = 0; V_{G1-S} = 5 \text{ V}$	_	50	nA
I _{G2-SS}	gate 2 cut-off current	$V_{G1-S} = V_{DS} = 0; V_{G2-S} = 5 \text{ V}$	_	50	nA

Note

1. R_{G1} connects gate 1 to V_{GG} = 5 V; see Fig.21.

DYNAMIC CHARACTERISTICS

Common source; T_{amb} = 25 °C; V_{DS} = 5 V; V_{G2-S} = 4 V; I_D = 10 mA; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
y _{fs}	forward transfer admittance	pulsed; T _j = 25 °C	22	25	30	mS
C _{ig1-s}	input capacitance at gate 1	f = 1 MHz	_	2.2	2.6	pF
C _{ig2-s}	input capacitance at gate 2	f = 1 MHz	1	1.5	2	pF
C _{os}	drain-source capacitance	f = 1 MHz	1	1.4	1.7	pF
C _{rs}	reverse transfer capacitance	f = 1 MHz	_	25	35	fF
F	noise figure	$f = 200 \text{ MHz}; G_S = 2 \text{ mS}; B_S = B_{Sopt}$	_	1	1.5	dB
		$f = 800 \text{ MHz}$; $G_S = G_{Sopt}$; $B_S = B_{Sopt}$	_	2	2.8	dB

N-channel dual gate MOS-FETs

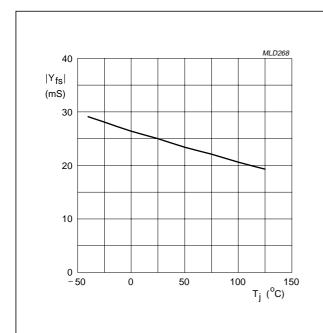
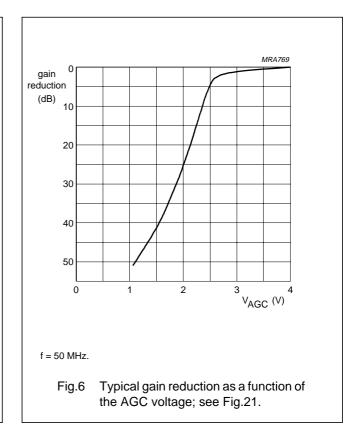
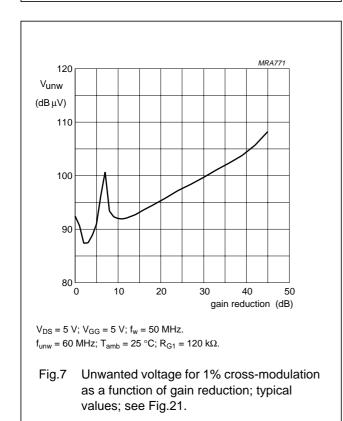
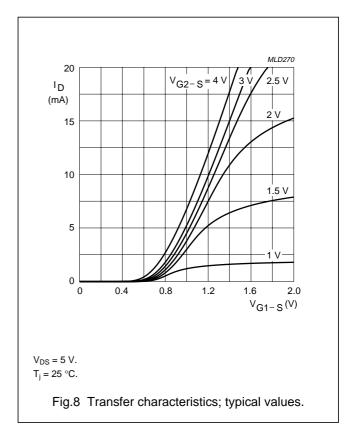


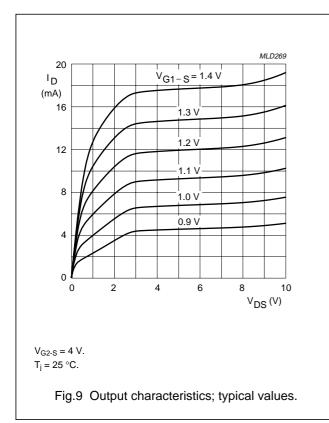
Fig.5 Transfer admittance as a function of the junction temperature; typical values.

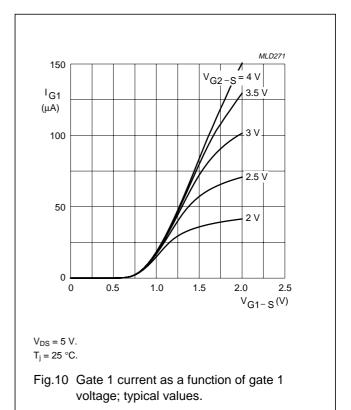


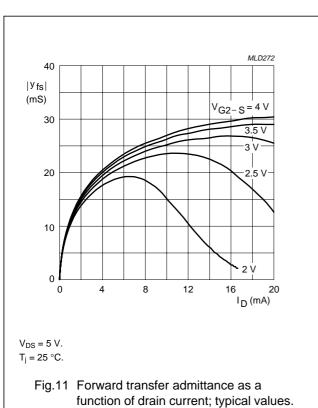


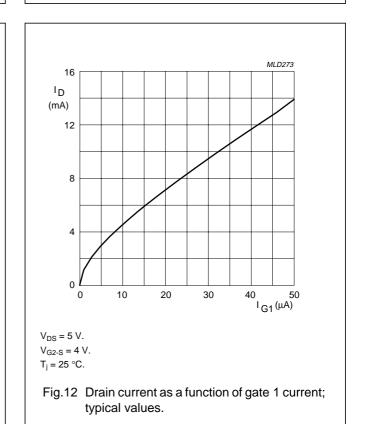


N-channel dual gate MOS-FETs



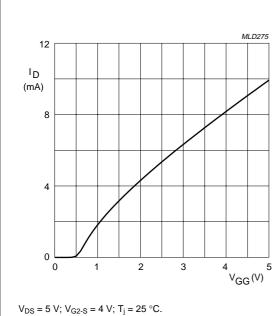






N-channel dual gate MOS-FETs

BF904A; BF904AR; BF904AWR



 $V_{DS} = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $T_j = 25 \text{ °C}$. $R_{G1} = 120 \text{ k}\Omega$ (connected to V_{GG}); see Fig.21.

Fig.13 Drain current as a function of gate 1 supply voltage (= V_{GG}); typical values.

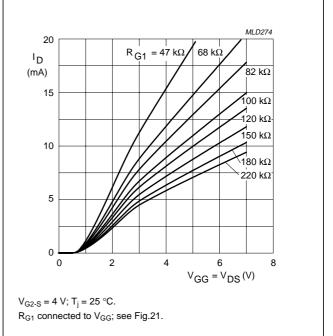
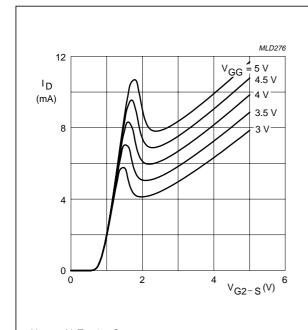


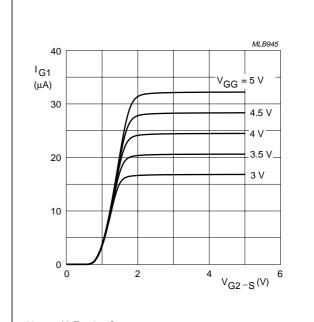
Fig.14 Drain current as a function of gate 1 (= V_{GG}) and drain supply voltage; typical values.



 V_{DS} = 5 V; T_j = 25 °C.

 R_{G1} = 120 $k\Omega$ (connected to $V_{GG});$ see Fig.21.

Fig.15 Drain current as a function of gate 2 voltage; typical values.



 V_{DS} = 5 V; T_{j} = 25 °C.

 R_{G1} = 120 $k\Omega$ (connected to $V_{GG});$ see Fig.21.

Fig.16 Gate 1 current as a function of gate 2 voltage; typical values.

N-channel dual gate MOS-FETs

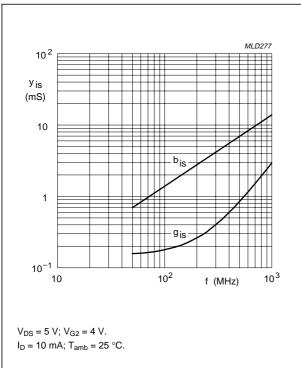


Fig.17 Input admittance as a function of frequency; typical values.

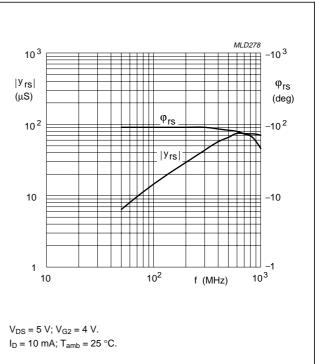
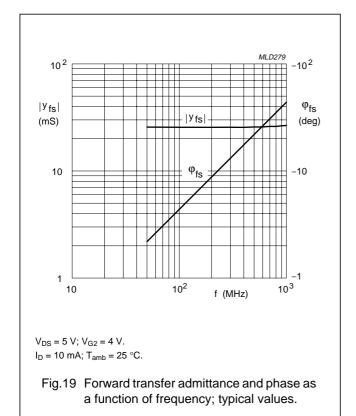
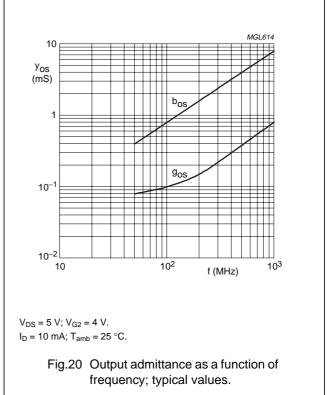
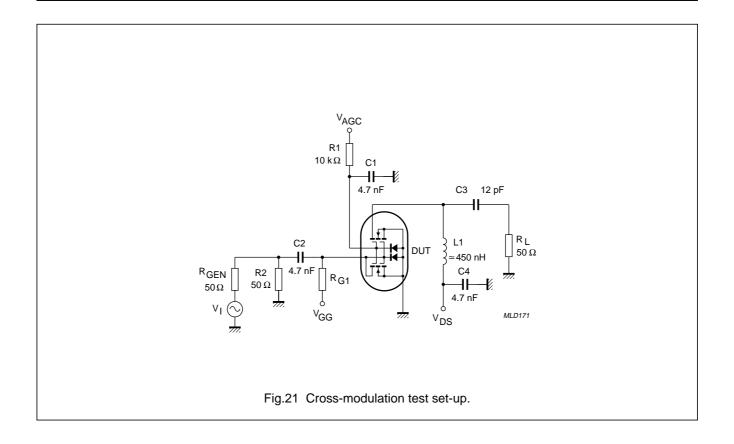


Fig.18 Reverse transfer admittance and phase as a function of frequency; typical values.





N-channel dual gate MOS-FETs



N-channel dual gate MOS-FETs

Table 1 Scattering parameters: $V_{DS} = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $I_D = 10 \text{ mA}$; $T_{amb} = 25 ^{\circ}\text{C}$

f	S ₁₁		S ₂₁		S ₁₂		S ₂₂	
(MHz)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)
40	0.989	-3.2	2.52	175.9	0.001	87.9	0.989	-1.7
100	0.987	-7.9	2.52 169.4 0.001 86.1 0.988		0.988	-4.3		
200	0.976	-15.7	2.47	159.2	0.003	81.4	0.984	-8.6
300	0.972	-23.3	2.43	150.5	0.004	80.5	0.985	-12.7
400	0.947	-30.6	2.36	139.6	0.005	76.9	0.975	-16.9
500	0.925	-37.6	2.26	130.3	0.005	75.6	0.968	-20.8
600	0.905	-44.4	2.19	121.1	0.005	75.5	0.961	-24.7
700	0.883	-50.9	2.10	112.3	0.006	78.0	0.954	-28.4
800	0.861	-57.0	2.01	103.6	0.006	85.3	0.946	-32.0
900	0.841	-63.0	1.93	95.5	0.006	90.7	0.934	-35.6
1000	0.822	-68.4	1.85	87.8	0.006	102.6	0.931	-39.3
1200	0.787	-78.9	1.71	72.3	0.007	127.1	0.923	-46.7
1400	0.752	-88.1	1.59	57.3	0.011	143.7	0.926	-54.2
1600	0.723	-97.3	1.47	40.1	0.019	150.0	0.935	-62.2
1800	0.685	-106.3	1.36	25.0	0.021	149.4	0.931	-69.3
2000	0.665	-114.0	1.31	7.7	0.026	151.5	0.930	-77.7
2200	0.659	-119.8	1.30	-14.0	0.035	158.2	0.944	-89.1
2400	0.670	-124.2	1.26	-42.2	0.050	163.4	0.941	-103.5
2600	0.700	-129.3	1.10	-78.2	0.076	162.2	0.849	-119.7
2800	0.729	-138.7	0.82	-120.8	0.106	150.5	0.642	-130.9
3000	0.726	-150.1	0.52	-162.8	0.128	137.4	0.480	-130.6

Table 2 Noise data: $V_{DS} = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $I_D = 10 \text{ mA}$; $T_{amb} = 25 ^{\circ}\text{C}$

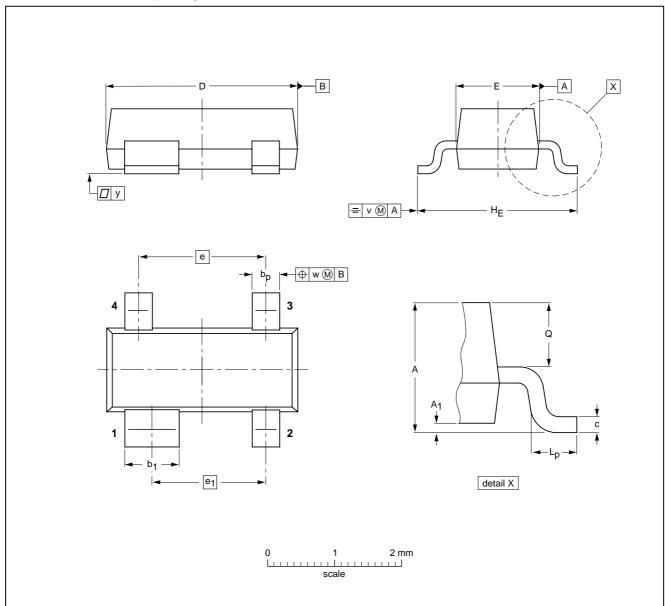
f	F _{min}	Γ	opt	R _n
(MHz)	(dB)	(ratio)	(deg)	(Ω)
800	2.0	0.686	49.6	50.4

BF904A; BF904AR; BF904AWR

PACKAGE OUTLINES

Plastic surface mounted package; 4 leads

SOT143B



DIMENSIONS (mm are the original dimensions)

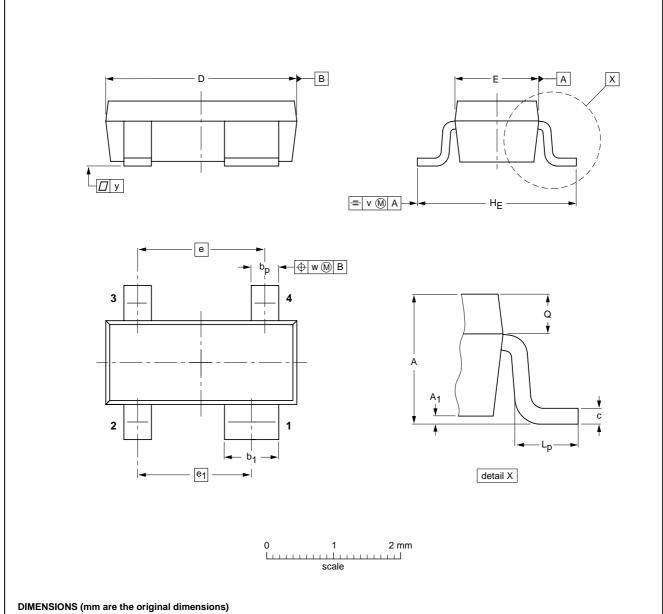
UNIT	A	A ₁ max	bp	b ₁	С	D	E	е	e ₁	HE	L _p	Q	v	w	у
mm	1.1 0.9	0.1	0.48 0.38	0.88 0.78	0.15 0.09	3.0 2.8	1.4 1.2	1.9	1.7	2.5 2.1	0.45 0.15	0.55 0.45	0.2	0.1	0.1

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT143B					97-02-28

BF904A; BF904AR; BF904AWR

Plastic surface mounted package; reverse pinning; 4 leads

SOT143R



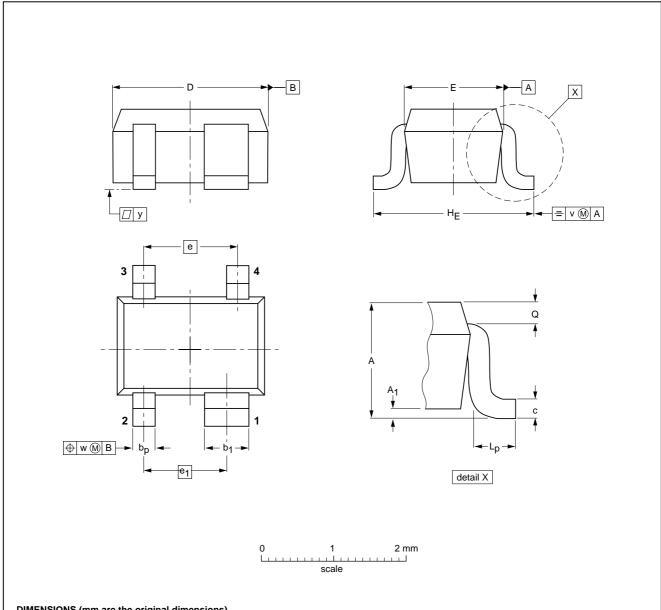
UNIT	A	A ₁ max	bp	b ₁	С	D	E	е	e ₁	HE	L _p	Q	v	w	у
mm	1.1 0.9	0.1	0.48 0.38	0.88 0.78	0.15 0.09	3.0 2.8	1.4 1.2	1.9	1.7	2.5 2.1	0.55 0.25	0.45 0.25	0.2	0.1	0.1

OUTLINE		REFER	ENCES		EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEDEC EIAJ PROJECT		PROJECTION	ISSUE DATE
SOT143R						97-03-10

BF904A; BF904AR; BF904AWR

Plastic surface mounted package; reverse pinning; 4 leads

SOT343R



DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁ max	bp	b ₁	С	D	E	е	e ₁	HE	Lp	Q	v	w	у
mm	1.1 0.8	0.1	0.4 0.3	0.7 0.5	0.25 0.10	2.2 1.8	1.35 1.15	1.3	1.15	2.2 2.0	0.45 0.15	0.23 0.13	0.2	0.2	0.1

OUTLINE VERSION		REFER	EUROPEAN	ISSUE DATE		
	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT343R						97-05-21

BF904A; **BF904AR**; **BF904AWR**

N-channel dual gate MOS-FETs

Legal information

Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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Revision history

Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BF904A_AR_AWR_N_4	20071113	Product data sheet	-	BF904A_AR_AWR_3
Modifications:	Fig. 1 and 2	on page 2; Figure note change	ed	
BF904A_AR_AWR_3 (9397 750 05271)	19990514	Product specification	-	BF904A_AR_AWR_N_2
BF904A_AR_AWR_N_2 (9397 750 05234)	19990201	Preliminary specification	-	BF904A_AR_AWR_N_1
BF904A_AR_AWR_N_1 (9397 750 04748)	19981130	Preliminary specification	-	-

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